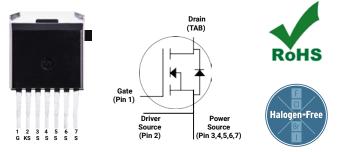


Silicon Carbide Power MOSFET C3M™ MOSFET Technology N-Channel Enhancement Mode

Features

- 3rd generation Solicon Carbide (SiC) MOSFET technology
- Low impedance package with driver source pin
- 7mm of creepage distance between drain and source
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_{rr})
- Halogen free, RoHS compliant



Wolfspeed, Inc. is in the process of rebranding its products and related materials pursuant to the entity name change from Cree, Inc. to Wolfspeed, Inc. During this transition period, products received may be marked with either the Cree name and/or logo or the Wolfspeed name and/or logo.

Part Number	Package	Marking	
C3M0160120J	TO 263-7	C3M0160120J	

Typical Applications

- Renewable energy
- High voltage DC/DC converters
- Switch Mode Power Supplies
- UPS

Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

Key Parameters

Parameter	Symbol	Min.	Тур.	Max	Unit	Conditions	Note
Drain - Source Voltage	V _{DS}			1200		T _c = 25°C	
Maximum Gate - Source Voltage	V _{GS(max)}	-8		+19	v	Transient	
Operational Gate-Source Voltage	V _{GS op}		-4/15			Static	Note 1
DC Continuous Drain Current	I _D			17	A	$V_{GS} = 15 \text{ V}, T_{C} = 25 \text{ °C}, T_{J} \le 150 \text{ °C}$	Fig. 19 Note 2
				12		$V_{GS} = 15 \text{ V}, T_{C} = 100 \text{ °C}, T_{J} \le 150 \text{ °C}$	
Pulsed Drain Current	I _{DM}			34		t_{Pmax} limited by T_{jmax} $V_{GS} = 15V$, $T_{C} = 25$ °C	Fig. 22
Power Dissipation	P _D			90	w	$T_{c} = 25 ^{\circ} \text{C}, T_{J} = 150 ^{\circ} \text{C}$	Fig. 20
Operating Junction and Storage Temperature	T _J , T _{stg}			-55 to +150	°C		
Solder Temperature	T _L			260		According to JEDEC J-STD-020	

 $Note~(1): Recommended~turn-on~gate~voltage~is~15V~with~\pm5\%~regulation~tolerance, see~Application~Note~PRD-04814~for~additional~details~tolerance, see~Application~details~tolerance, see~Application~de$

Note (2): Verified by design

Electrical Characteristics ($T_c = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Conditions	Note	
Gate Threshold Voltage	V	1.8	2.8	3.6	V	$V_{DS} = V_{GS}$, $I_{D} = 2.33$ mA	Fig. 11	
Gate Tireshold Voltage	$V_{GS(th)}$	_	2.2	_	V	$V_{DS} = V_{GS}$, $I_{D} = 2.33$ mA, $T_{J} = 150$ °C		
Zero Gate Voltage Drain Current	I _{DSS}	_	1	100	μΑ	$V_{DS} = 1200 \text{ V}, V_{GS} = 0 \text{ V}$		
Gate-Source Leakage Current	I _{GSS}	_	10	250	nA	$V_{GS} = 15 \text{ V}, V_{DS} = 0 \text{ V}$		
Dunin Course On State Perintense		_	160	208		$V_{GS} = 15 \text{ V}, I_D = 8.5 \text{ A}$	Fig.	
Drain-Source On-State Resistance	R _{DS(on)}	_	256	_	mΩ	$V_{GS} = 15 \text{ V}, I_D = 8.5 \text{ A}, T_J = 150^{\circ}\text{C}$	4, 5, 6	
Transconductance	_		5.2		S	$V_{DS} = 20 \text{ V}, I_{DS} = 8.5 \text{ A}$	Fig. 7	
Transconductance	g fs	_	4.9	_	3	$V_{DS} = 20 \text{ V}, I_{DS} = 8.5 \text{ A}, T_{J} = 150 ^{\circ}\text{C}$		
Input Capacitance	C _{iss}	_	632	_			Fig. 17, 18	
Output Capacitance	C _{oss}	_	39	_	pF	$V_{GS} = 0 \text{ V}, V_{DS} = 1000 \text{ V}$ f = 1 Mhz		
Reverse Transfer Capacitance	C _{rss}	_	3	_		$V_{AC} = 25 \text{ mV}$		
Coss Stored Energy	E _{oss}	_	22.5	_		7.0	Fig. 16	
Turn-On Switching Energy (Body Diode FWD)	Eon	_	64	_	μJ	$V_{DS} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_{D} = 8.5 \text{ A},$	Fig.	
Turn Off Switching Energy (Body Diode FWD)	E _{off}	_	13	_		$R_{G(ext)} = 0 \Omega$, L= 336 μ H	26, 29	
Turn-On Delay Time	t _{d(on)}	_	11	_		$V_{DD} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$	Fig.	
Rise Time	t _r	_	8	_	nc	$I_D = 8.5 \text{ A}, R_{G(ext)} = 0 \Omega,$		
Turn-Off Delay Time	t _{d(off)}	_	14	_	Timing relative to V _{DS}		27, 28, 29	
Fall Time	t _f	_	8	_		Inductive load		
Internal Gate Resistance	R _{G(int)}	_	0	_	Ω	$f = 1 \text{ MHz}, V_{AC} = 25 \text{ mV}$		
Gate to Source Charge	Q_{gs}	_	11	_		$V_{DS} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$		
Gate to Drain Charge	Q_{gd}	_	5	_	nC	I _D = 8.5 A	Fig. 12	
Total Gate Charge	Qg	_	24	_		Per IEC60747-8-4 pg 21		

Reverse Diode Characteristics ($T_c = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Тур.	Max.	Unit	Test Conditions	Notes	
Diada Famuard Valtara	V	4.4	_	V	$V_{GS} = -4 \text{ V}, I_{SD} = 3 \text{ A}$	Fig.	
Diode Forward Voltage	V_{SD}	4.0	_		V _{GS} = -4 V, I _{SD} = 3 A, T _J = 150°C	8, 9, 10	
Continuous Diode Forward Current	Is	_	17		$V_{GS} = -4 \text{ V}, T_{J} = 25^{\circ}\text{C}$		
Diode Pulse Current	I _{S, pulse}	_	34	А	$V_{GS} = -4 V$, pulse width t_P limited by $T_{j max}$		
Reverse Recovery Time	t _{rr}	5	_	ns		– Fig. 29	
Reverse Recovery Charge	Qrr	65	_	nC	$V_{GS} = -4 \text{ V}, I_{SD} = 8.5 \text{ A}, V_{R} = 800 \text{ V}$ $di_{z}/dt = 8925 \text{ A}/\mu\text{s}, T_{J} = 25^{\circ}\text{C}$		
Peak Reverse Recovery Current	I _{RRM}	19	_	Α	αι _μ ατ 032377 μ3, 1		
Reverse Recovery Time	t _{rr}	7	_	ns			
Reverse Recovery Charge	Qrr	32	_	nC	$V_{GS} = -4 \text{ V}, I_{SD} = 8.5 \text{ A}, V_{R} = 800 \text{ V}$ $di_{z}/dt = 2020 \text{ A}/\mu\text{s}, T_{J} = 25^{\circ}\text{C}$		
Peak Reverse Recovery Current	I _{RRM}	8	_	Α	αι _μ ατ 2020 / γμο, τη 20 C		

Thermal Characteristics

Parameter	Symbol	Typ.	Unit	Note
Thermal Resistance from Junction to Case	$R_{\theta JC}$	1.38	°C/W	Fig. 21

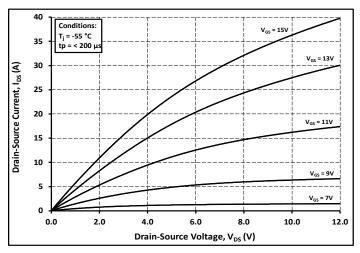


Figure 1. Output Characteristics T_J = -55°C

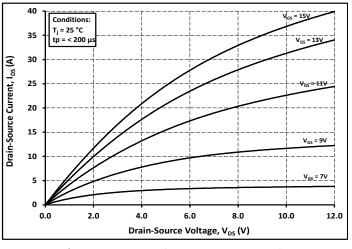


Figure 2. Output Characteristics T_J = 25°C

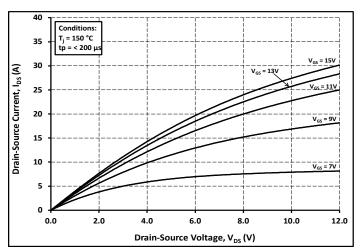


Figure 3. Output Characteristics T_J = 150°C

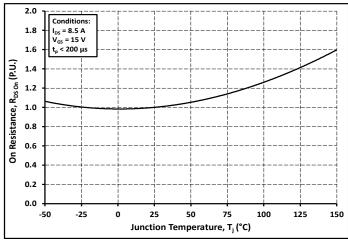


Figure 4. Normalized On-Resistance vs. Temperature

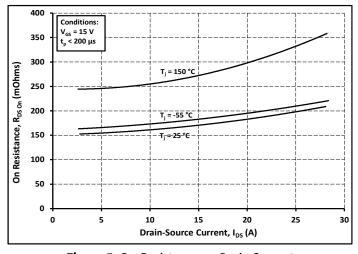


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

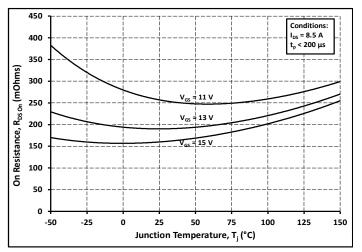


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

4

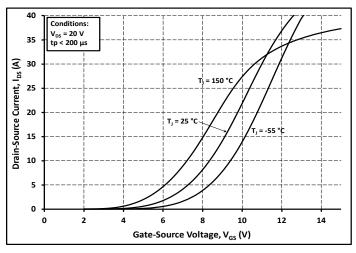


Figure 7. Transfer Characteristic for Various Junction Temperatures

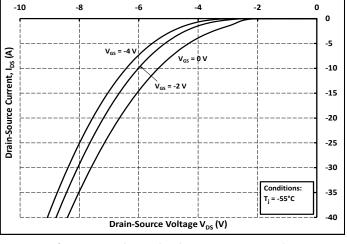


Figure 8. Body Diode Characteristic at -55°C

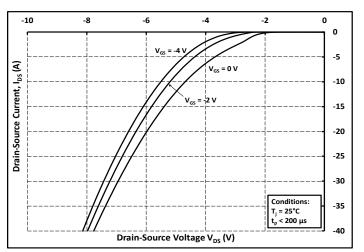


Figure 9. Body Diode Characteristic at 25°C

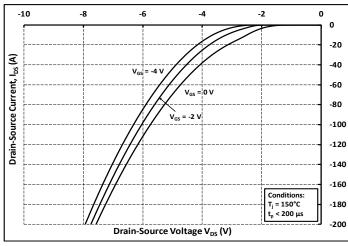


Figure 10. Body Diode Characteristic at 150°C

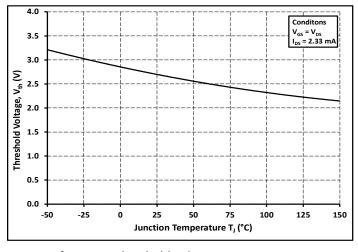


Figure 11. Threshold Voltage vs. Temperature

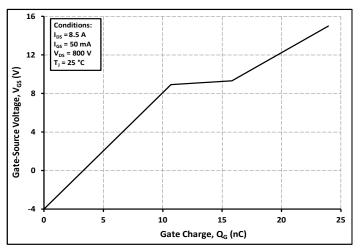


Figure 12. Gate Charge Characteristics

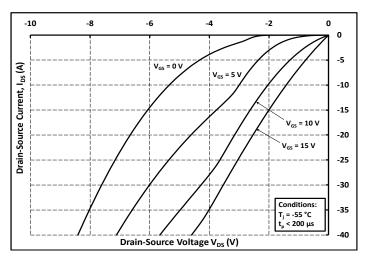


Figure 13. 3rd Quadrant Characteristic at -55°C

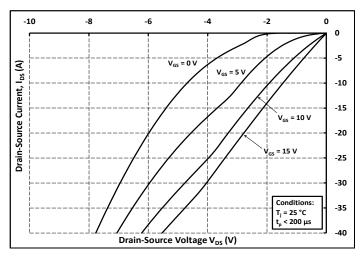


Figure 14. 3rd Quadrant Characteristic at 25°C

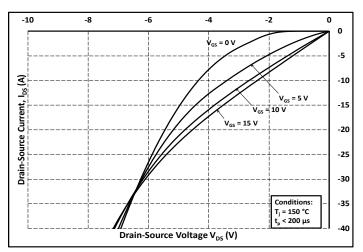


Figure 15. 3rd Quadrant Characteristic at 150°C

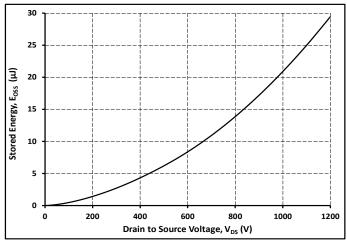


Figure 16. Output Capacitor Stored Energy

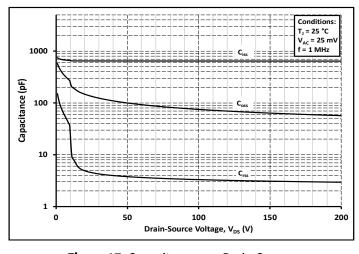


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200 V)

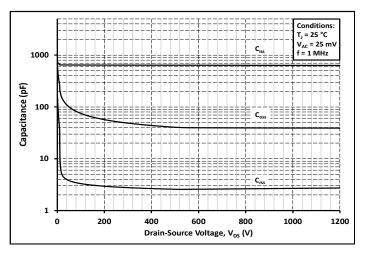


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1200 V)

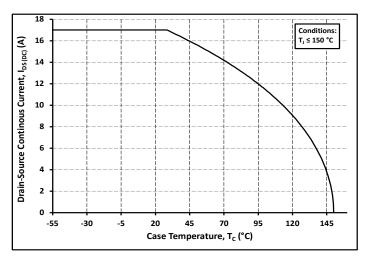


Figure 19. Continuous Drain Current Derating vs. Case Temperature

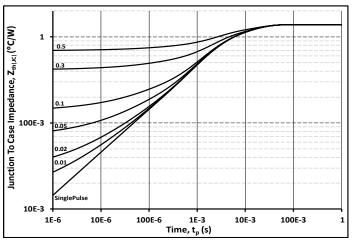


Figure 21. Transient Thermal Impedance (Junction - Case)

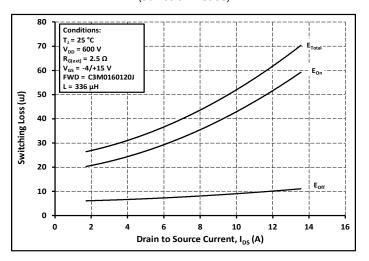


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 600 \text{ V}$)

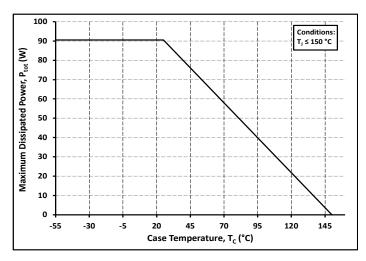


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

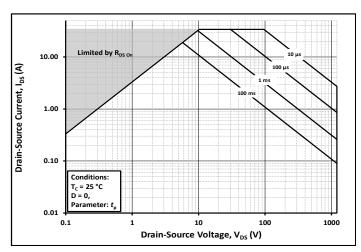


Figure 22. Safe Operating Area

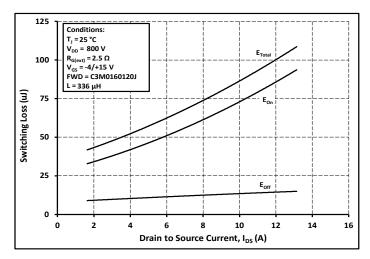


Figure 24. Clamped Inductive Switching Energy vs. Drain Current $(V_{DD} = 800 \text{ V})$

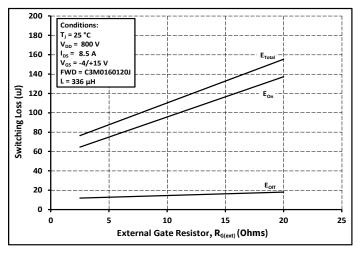


Figure 25. Clamped Inductive Switching Energy vs R_{G(ext)}

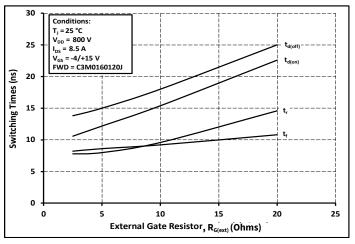


Figure 27. Switching Times vs R_{G(ext)}

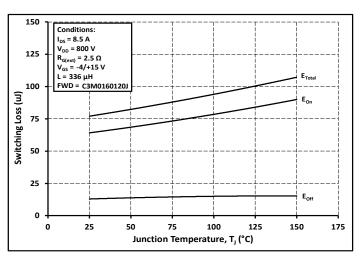


Figure 26. Clamped Inductive Switching Energy vs Temperature

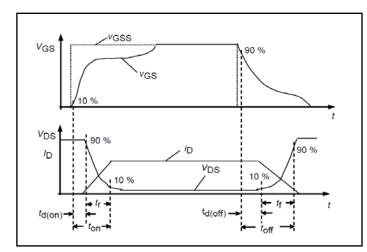


Figure 28. Switching Times Definition

Test Circuit Schematic

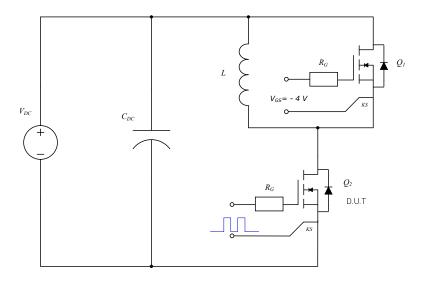
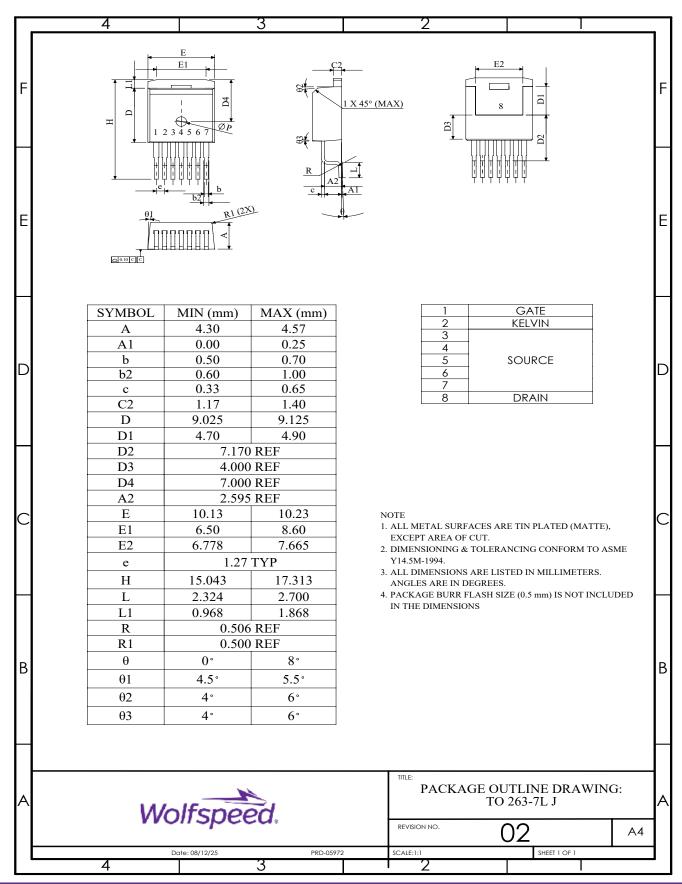


Figure 29. Clamped Inductive Switching Waveform Test Circuit

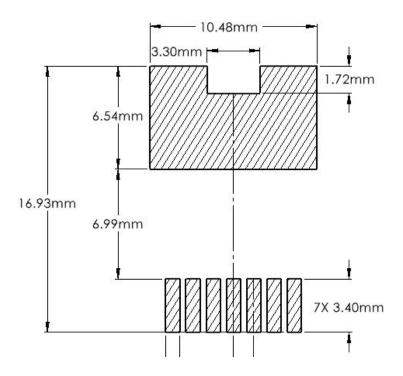
Note:

Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.

Package Dimensions - Package 7L D2PAK



Recommended Solder Pad Layout



Revision History

Current Revision	Date of Release	Description of Changes			
A	April-2020	N/A			
2	December-2023	Updated Wolfspeed branding, package drawing, package image, solder pad layout, added Rev history, Table 1 layout revised			
3	December - 2024	Legal Disclaimer Updated			
4	September - 2025	Package drawing updated to correct dimension D1			

Related Links

- <u>SiC MOSFET Isolated Gate Driver reference design</u>
- SiC MOSFET Evaluation Board

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